



## Inductance Analyzers - 3255BL 3255B and 3255BQ

- Frequency ranges from 20 Hz to 1 MHz
- Fast measurement speed - up to 20 measurements per second
- 0.1% basic accuracy
- Up to 125 A of DC bias current
- Comprehensive measurement functions
- Straightforward intuitive operation
- Print test results
- GPIB control with LabVIEW™ driver

### Completely characterize components with comprehensive parametric tests

The 3255B range of inductance analyzers are able to accurately characterise devices in a clear and simple manner. The inductance analyzers are available in three versions 3255BL (200kHz), 3255B (500kHz) and 3255BQ (1 MHz).

At the design stage of component development it is very important to analyse how components performs under different operating conditions. This includes operation over a range of frequencies, AC drive levels or DC bias currents.

The AC drive level can be set between 1 mV and 10 V. DC bias current can be set from 1 mA to 1 A internally (optional). Using the external 3265B range of DC Bias Units bias currents can be set to a maximum of 125 A.

### Specification summary

Measurement functions	Z, $\emptyset$ , L, C, Rac, Rdc, Q, D, turns ratio
Frequency ranges	20 Hz to 200kHz (3255BL) 20 Hz to 500 kHz (3255B) 20 Hz to 1 MHz (3255BQ)
Basic accuracy	0.1%
Modes	Impedance Multi frequency Bin handler (optional)
DC bias current	1 mA to 1 A - internal (optional)
Interface	GPIB (option)
Measurement speed	Up to 20 measurements/sec

### Printed output of test results

Using the parallel Centronics interface the user can directly print all test results for further analysis and archiving.

In addition, via the optional GPIB interface, the instrument can be controlled from a PC and results can be read back for analysis and storage.

LabVIEW™ drivers are available on request or can be downloaded from the web site, [www.waynekerrtest.com](http://www.waynekerrtest.com), providing a base from which a user can develop a specific test application.

## Bin sort

The binning function allows component manufacturers to sort components in up to ten bins. Sorting is carried out either by absolute values or by percentage of values.

## Component tests with up to 125 A DC bias current

The 3255B and 3255BQ enable components to be measured at up to 125 A when optional 3265B DC Bias Units are used. Extended DC bias capability is also available with the 3255BL which uses the 3265B/5A or 3265B/10A to extend the DC bias current available to a maximum of 50A.

Up to five of the DC Bias Units can be used in parallel to give a wide range of DC bias currents.

Internal DC bias is available as an option giving DC bias currents from 1 mA to 1 A.

The 3265B has a number of safety and protection features including a safety interlock system to protect users against back EMFs. It is also fully protected against over temperature, excess voltage drop and sense lead failure.



*3265B DC Bias Unit can deliver up to 25 A of DC bias current in steps of 0.025 A*

## SMD inductor tests up to 50 A

With the addition of the 1009 DC Bias Fixture DC bias currents up to 50 A can be applied to an SMD inductor during component test in order to evaluate the devices thoroughly at operational bias currents. The fixture operates with one or two 3265B/25A Wayne Kerr DC bias units and a 3255B Inductance Analyzer. If two 3265B/25As are used then the optional 5-328-2005 high current lead set will be required.

Four rear panel mounted BNC connectors and two captive high current cables ensure simplicity and ease of use with a 3265B.

Interchangeable component test carriers ensure that the 1009 test fixture may be used with a wide variety of different devices. Blank carriers are available which enable device specific test fixtures to be developed or alternatively a carrier design and manufacturing service is available.

Stable component fixturing ensures high accuracy and repeatable measurements. Enclosed fixtures, with safety interlocks, minimises risk to operators.



*1009 DC Bias Fixture enables currents up to 50 A to be applied to an SMD inductor*

## Technical specifications

### Operation modes

#### **Impedance mode**

Inductance (L), Impedance (Z), DC Resistance (Rdc) and Capacitance (C).

Series or parallel equivalent circuit

Loss term: Quality factor (Q), Dissipation factor (D),

AC Resistance (Rac) and Phase Angle ( $\phi$ ) Turns Ratio

Percentage difference mode and relative mode on major terms.

#### **Multi-frequency mode**

Measurement parameters and test conditions set using measurement mode. Up to eight frequencies with absolute or percentage limits on major term with PASS/FAIL indications.

### Test conditions

#### **Low level AC drive**

For measurement of L + Q, Ls + Rs, C, Z, Turns Ratio

#### **Frequency ranges**

20 Hz to 200 kHz (3255BL)

20 Hz to 500 kHz (3255B)

20 Hz to 1 MHz (3255BQ)

#### **Steps**

At least 800 frequency steps are available which may be selected via the keypad or GPIB.

Basic accuracy of selected frequency  $\pm 0.01\%$

#### **Drive level**

Source impedance 50  $\Omega$

1 mV to 10 V rms into open circuit

50  $\mu$ A to 200 mA rms into short circuit

Automatic Level Control (ALC) maintains level applied to Device Under Test (DUT) at  $\pm 2\%$ ,  $\pm 1$  mV of set voltage or  $\pm 2\% \pm 0.1$  mA of set current, reduces to  $\pm 4\%$  below 100 Hz.

#### **DC bias current (option)**

1mA to 1A DC is available from internal, fast settling bias supply over full frequency range.

Voltage compliance 14 V minimum

DC Accuracy  $\pm 2.5\% \pm 0.25$  mA

Enabling DC bias inherently reduces measurement accuracy.

Safety interlock eliminates operator exposure to high currents.

#### **DC resistance**

Low test level of 100 mV minimises heating of the DUT

Short circuit current 10 mA.

#### **Bin handler mode (option)**

Sort to 1 of 10 bins using absolute or percentage limits. Separate Pass/Fail output.

Up to 100 bin limit set-ups stored in non-volatile memory.

TTL interface to external bin handler via 25 way D type connector.

#### **Option /D1 (non-isolated)**

Common 0 V. Bin outputs 0 to 5 V(nominal) with  $>10$  mA current sink capability.

#### **Option /D2 (isolated)**

Common 24 V input. Outputs 0 to 24 V with  $>10$  mA current source capability.

### Measurement speeds

For Impedance, Turns Ratio, DC Resistance

4 speeds selectable for all functions: MAXimum, FAST, MEDium and SLOW

Maximum for remote control. Up to 20 measurements per second for test frequency  $\geq 100$  Hz. Selecting slower speeds improves accuracy and display resolution.

### Measurement ranges

R 0.05 m $\Omega$  to  $>2$  M $\Omega$

L 1 nH to  $>1000$  H

C 0.01 pF to  $>250$  mF

Rdc 0.5 m $\Omega$  to 50 k $\Omega$

Turns Ratio 100:1 to 1:100

### Accuracy

L/C/Z/Turns Ratio  $\pm 0.1\%$

Q  $\pm 0.1\%$  (Q+1/Q)

D  $\pm 0.001$  (1+D<sup>2</sup>)

Rdc  $\pm 0.5\% \pm 1$  m $\Omega$

Note: Ranges and accuracy vary with measurement speed, frequency and options chosen

## General data

### Input specification

Power supply  
230 V AC  $\pm 10\%$  or  
115 V AC  $\pm 10\%$  (selectable)  
50 to 400 Hz  
150 VA maximum consumption

### Display

High contrast monochrome LCD  
320 x 240 dot with back lighting.  
Visible area 115 x 86mm.  
Viewing angle 45°

### Measurement connections

4 front panel BNC sockets  
4-wire (Kelvin) measurements with screen at ground potential  
Equivalent circuit symbols on screen

### Remote control (option)

Conforms with GPIB IEEE-488.2 and SCPI 1992.0

### Printer output

Centronics/parallel printer port

### Environmental conditions

Temperature range  
Storage -40 °C to 70 °C  
Operating 0 °C to 40 °C  
Full Accuracy 15 °C to 35 °C

Altitude up to 2000m  
Relative humidity: up to 80% non-condensing  
Installation category: II (in accordance with IEC664)  
Pollution degree: 2 (mainly nonconductive)  
This equipment is intended for indoor use only in non-explosive, non-corrosive atmosphere.

### Safety

Complies with the requirements of EN61010-1

### EMC

Complies with EN50081-1, EN50082-1 generic emissions and immunity standards by meeting with the requirements of EN55022, IEC801.2, IEC801.3 and IEC801.4

### Mechanical (approx. overall)

Height 150 mm (6")  
Width 440 mm (17 <sup>3</sup>/<sub>8</sub>")  
Depth 520 mm (20 <sup>1</sup>/<sub>2</sub>")  
Weight 11 kg (24 lb 4 oz)

## Order codes and options

### Description

3255BL Inductance Analyzer – 200 kHz  
Supplied with user manual and power cable

### Order code

**1J3255BL**

3255B Inductance Analyzer – 500 kHz  
Supplied with user manual and power cable

**1J3255B**

3255BQ Inductance Analyzer - 1 MHz  
Supplied with user manual and power cable

**1J3255BQ**

### Options

/A 1 mA to 1 A internal DC bias  
/B GPIB (IEEE-488) interface  
/D1 Bin handler (cannot be fitted with /D2)  
/D2 Bin handler opto-coupled (cannot be fitted with /D1)

### Auxiliary unit

5A DC bias unit 3265B/5A **1J3265B/5A**

10A DC bias unit 3265B/10A **1J3265B/10A**

20A DC bias unit 3265B/20A **1J3265B/20A**  
(Not compatible with 3255BL)

25A DC bias unit 3265B/25A **1J3265B/25A**  
(Not compatible with 3255BL)

All auxiliary units are supplied with user manual, power cable, spare fuses, 4 x BNC to BNC links and daisy chain link.

### Accessories

#### Description

1009 DC Bias Fixture  
High current lead set for 1009  
Kelvin clips (fine jaws).  
Kelvin clips (large jaws)  
4-terminal lead set  
SMD Tweezers  
Bus bars  
Rack mounting kit, 3U x full width  
(Unit needs rear support)

#### Order code

**1J1009**  
**5-328-2005**  
**1EVA40100**  
**1EVA40180**  
**1EV1505**  
**1EVA40120**  
**4-324-6009**  
**1EXA20230**

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